



Low Power Quint Exclusive OR/NOR Gate

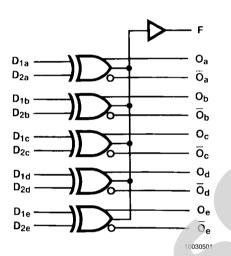
General Description

The 100307 is monolithic quint exclusive-OR/NOR gate. The Function output is the wire-OR of all five exclusive-OR outputs. All inputs have 50 k Ω pull-down resistors.

Features

- Low Power Operation
- 2000V ESD protection
- Pin/function compatible with 100107
- Voltage compensated operating range = -4.2V to -5.7V
- Available to industrial grade temperature range
- Available to Standard Microcircuit Drawing (SMD) 5962-9459001

Logic Symbol

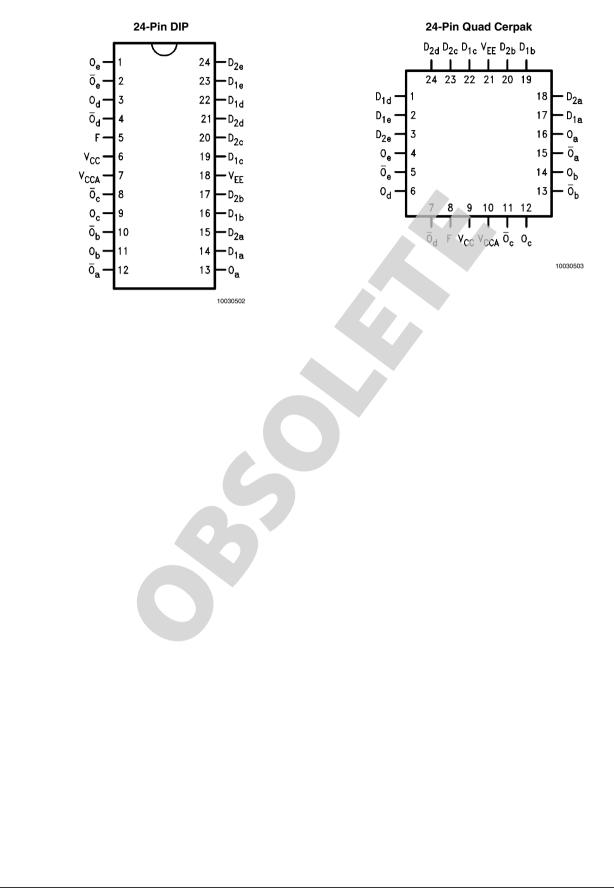


Logic Equation

$$\begin{split} F &= (D_{1a} + D_{2a}) + (D_{1b} + D_{2b}) + (D_{1c} + D_{2c}) + (D_{1d} + D_{2d}) + \\ (D_{1e} + D_{2e}). \end{split}$$

Pin Names	Description
D _{na} -D _{ne}	Data Inputs
F	Function Output
O _a -O _e	Data Outputs
$\overline{O}_{a} - \overline{O}_{e}$	Complementary
	Data Outputs

Connection Diagrams



Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

Above which the useful life may be impaired. (Note 1)					
Storage Temperature (T _{STG})	–65°C to +150°C				
Maximum Junction Temperature (T _J)					
Ceramic	+175°C				
Plastic	+150°C				
V _{EE} Pin Potential to Ground Pin	-7.0V to +0.5V				
Input Voltage (DC)	V _{EE} to +0.5V				

Military Version DC Electrical Characteristics

55°C to 105°C ٠*،*

Output Current (DC Output HIGH) ESD (Note 2)

–50 mA ≥2000V 00307

Recommended Operating Conditions

Case Temperature (T_{C}) Military

Supply Voltage (V_{FF})

-55°C to +125°C -5.7V to -4.2V

Note 1: Absolute maximum ratings are those values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: ESD testing conforms to MIL-STD-883, Method 3015.

Symbol	Parameter	Min	Max	Units	т _с	Conc	litions	Notes
/ _{он}	Output HIGH Voltage	-1025	-870	mV	0°C to			
					+125°C			
		-1085	-870	mV	–55°C	$V_{IN} = V_{IH}$ (Max)	Loading with	1, 2, 3
OL	Output LOW Voltage	-1830	-1620	mV	0°C to	or V _{IL} (Min)	50Ω to -2.0V	
					+125°C			
		-1830	-1555	mV	–55°C			
/ _{онс}	Output HIGH Voltage	-1035		mV	0°C to			
					+125°C			
		-1085		mV	– 5 5°C	V _{IN} = V _{IH} (Min)	Loading with	1, 2, 3
OLC	Output LOW Voltage		-1610	mV	0°C to	or V _{IL} (Max)	50Ω0 to -2.0V	
					+125°C			
			-1555	mV	_55°C			
/ _{ін}	Input HIGH Voltage	-1165	-870	mV	–55°C	Guaranteed HIGH Signal		1, 2, 3, 4
					+125°C	for All Inputs		
/ _{IL}	Input LOW Voltage	-1830	-1475	nV	–55°C to	Guaranteed LOW Signal		1, 2, 3,4
					+125°C	for All Inputs		
L	Input LOW Current	0.50		μA	–55°C to	$V_{EE} = -4.2V$ $V_{IN} = V_{IL}$ (Min)		1, 2, 3
					+125°C			
н	Input High Current							
	D _{2a} -D _{2e}		250	μA	0°C to			
	D _{1a} -D _{1e}		350		+125°C	$V_{EE} = -5.7V$		1, 2, 3
	D _{2a} -D _{2e}		350	μA	–55°C	$V_{IN} = V_{IH}$ (Max)		
	D _{1a} -D _{1e}		500					
ΞE	Power Supply Current	-75	-25	mA	–55°C to	Inputs Open		1, 2, 3
					+125°C			

Note 3: F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals -55°C), then testing immediately without allowing for the junction temperature to stabilize due to heat dissipation after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.

Note 4: Screen tested 100% on each device at -55°C, +25°C, and +125°C, Subgroups 1, 2 3, 7, and 8.

Note 5: Sample tested (Method 5005, Table I) on each manufactured lot at -55°C, +25°C, and +125°C, Subgroups A1, 2, 3, 7, and 8.

Note 6: Guaranteed by applying specified input condition and testing V_{OH}/V_{OL}.

AC Electrical Characteristics

$V_{EE} = -4.2V$ to $-5.7V$,	$V_{CC} = V_{CCA}$	$_{\Lambda} = GND$
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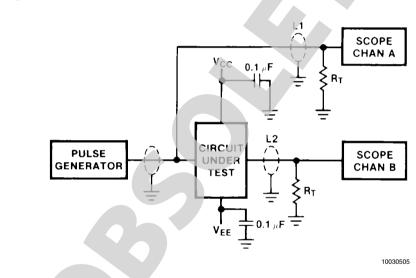
Symbol	Parameter	T _c = ·	T _C = -55°C		T _C = +25°C		T _C = +125°C		Conditions	Notes
		Min	Max	Min	Max	Min	Max	1		
t _{PLH}	Propagation Delay	0.30	2.10	0.40	1.90	0.40	2.40	ns		
t _{PHL}	D_{2a} - D_{2e} to O, \overline{O}									
t _{PLH}	Propagation Delay	0.30	1.90	0.40	1.80	0.40	2.20	ns		1, 2, 3
t _{PHL}	D_{1a} - D_{1e} to O, \overline{O}								Figures 1, 2	
t _{PLH}	Propagation Delay	0.80	2.90	0.90	2.80	0.90	3.40	ns	-	
t _{PHL}	Data to F									
t _{TLH}	Transition Time	0.20	1.70	0.30	1.60	0.20	1.70	ns		4
t _{THL}	20% to 80%, 80% to 20%									

Note 7: F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals –55°C), then testing immediately after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.

Note 8: Screen tested 100% on each device at +25°C temperature only, Subgroup A9.

Note 9: Sample tested (Method 5005, Table I) on each mfg. lot at +25°C, Subgroup A9, and at +125°C and -55°C temperatures, Subgroups A10 and A11. **Note 10:** Not tested at +25°C, +125°C, and -55°C temperature (design characterization data).

Test Circuitry



Notes:

V_{CC}, V_{CCA} = +2V, V_{EE} = -2.5V L1 and L2 = equal length 50Ω impedance lines R_T = 50Ω terminator internal to scope Decoupling 0.1 μF from GND to V_{CC} and V_{EE} All unused outputs are loaded with 50Ω to GND C_L = Fixture and stray capacitance ≤ 3 pF

FIGURE 1. AC Test Circuit

Switching Waveforms

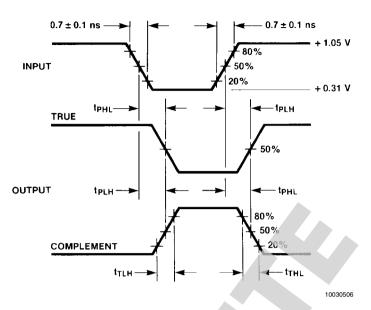
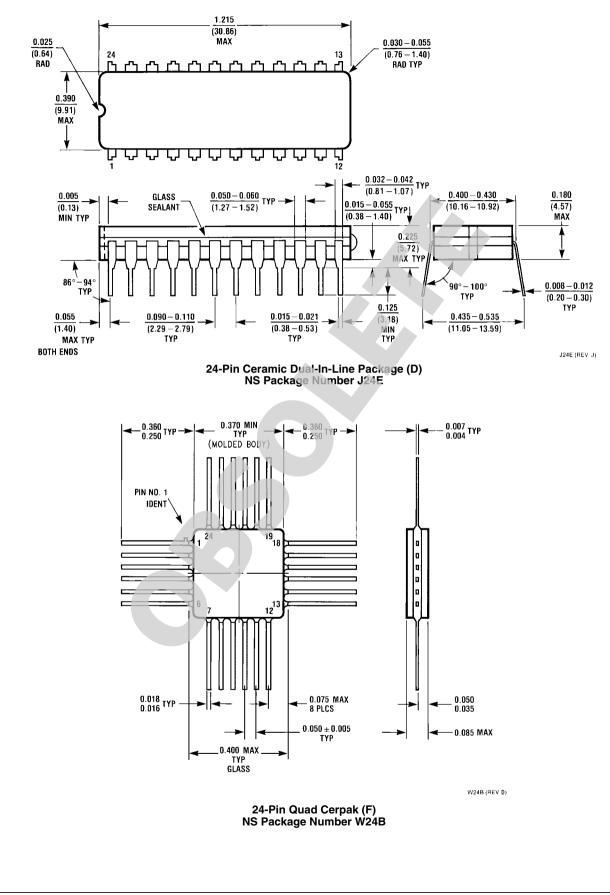


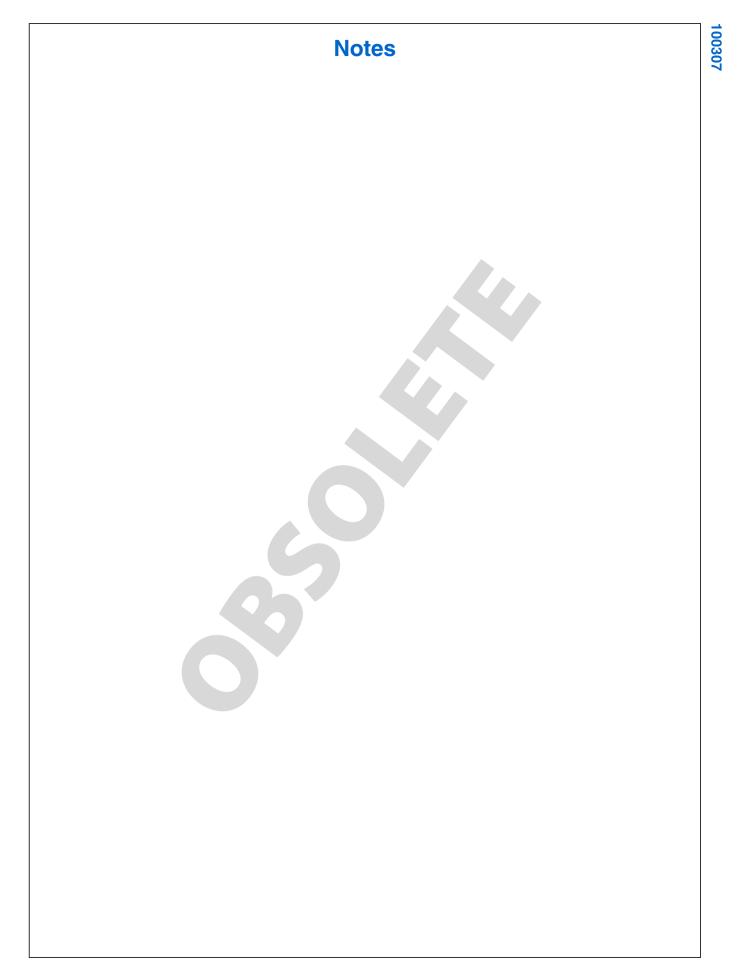
FIGURE 2. Propagation Delay and Transition Times

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Physical Dimensions inches (millimeters) unless otherwise noted





Notes

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OR/NOR G	For more National Se
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<u> </u>	Amplifiers
S	Audio
л С	Clock and Timing
Exclusive	Data Converters
	Interface
int	LVDS
	Power Managemen
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л Г	LDOs
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